



BSI Standards Publication

Dynamic on-resistance test method guidelines for GaN HEMT based power conversion devices

National foreword

This British Standard is the UK implementation of EN IEC 63373:2022. It is identical to IEC 63373:2022.

The UK participation in its preparation was entrusted to Technical Committee EPL/47, Semiconductors.

A list of organizations represented on this committee can be obtained on request to its committee manager.

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